

CNC Video Measuring System

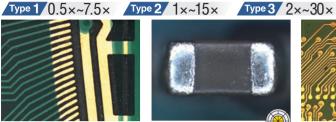
NEXIV



NEXIV VMZ-R Series

Optical Heads

Type 1, 2 and 3 - Standard magnification zooming heads



(optical magnification 1x) Type 1 / 8 segment LED ring light

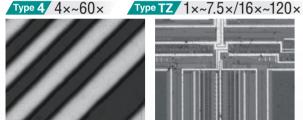


(optical magnification 2x) Type 2 / 8 segment LED ring light

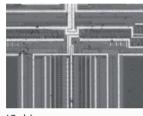


High density PCB (optical magnification 1x) Type 2 / coaxial top light

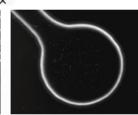
Type 4 and TZ - High magnification zooming heads



High density PCB (optical magnification 16x) Type 4 / coaxial top light



(optical magnification 8x) Type 4 / coaxial top light



High density PCB (optical magnification 16x) Type TZ / dark field illumination

Type A $0.35 \times \sim 3.5 \times$

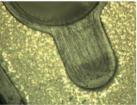




Type A - Wide FOV zooming head



Plastic molded part (optical magnification 0.35×) Coaxial top light



Plastic molded part (optical magnification 0.6x) Coaxial top light



Resin parts (optical magnification 0.35×) 8 segment LED ring light

Stage Sizes

$300\text{mm}(X) \times 200\text{mm}(Y) \times 200\text{mm}(Z)$ – Standard stroke

VMZ-R 3020

Suitable for small components used for products such as mechanical, electric/ electronic, automotive, and medical devices.

parts, implant components, watch components, etc.

Connectors, semiconductor packages, small PCB's, small stamped sheet metal parts, lead frames, watch components, etc.

Type 4/TZ High density PCB's, lead frames, semiconductor packages, MEMS,

probe cards, etc. Plastic molded parts, sheet metal parts, rubber parts, mechanical

$450\text{mm}(X) \times 400\text{mm}(Y) \times 200\text{mm}(Z) - \text{Middle stroke}$

VMZ-R 4540

Designed for middle size components and/or series measurements of multiple pieces on the stage.

Type 1~3 Middle size PCB's, stamped sheet metal parts, etc. Type 4/TZ 300mm wafers, 300mm probe cards, etc.

Middle size mechanical parts, plastic molded parts, etc.

650mm(X) × 550mm(Y) × 200mm(Z) – Large stroke

VMZ-R 6555

Suitable for large size components and/or "step-and-repeat" measurements of multiple pieces on the stage.

Type 1~3 Large PCB's, large plastic molded parts, etc.

Type 4/TZ High density large PCB's, etc.

Large stamped sheet metal parts, Large plastic molded parts, etc.



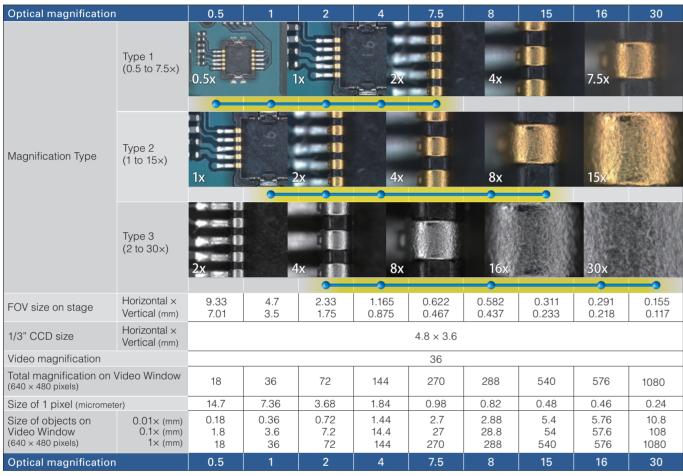
Optical magnificat	ion		0.35	0.5	0.6	1	1.8	2	3.5	4	7.5	8	15	16	30	32	60	64	120
Standard magnification zooming heads Type 1 Type 2 Type 3		Type 1				•		0		•									
		Type 2				•		-		-			_						
		Type 3						•		-				-	-				
High magnification zooming heads Type 4 Type TZ		Type 4								•		-		-		9			
		Type TZ				<u> </u>		-		-	-			-		9		-	
Wide FOV zooming h	ead	Type A	•		•	•	0		-										
FOV size on stage	Horizontal (mm) × Vertice	al (mm)	13.3 10.0	9.33 7.01	7.8 5.8	4.7 3.5	2.6 1.9	2.33 1.75	1.33 1.00	1.165 0.875	0.622 0.467	0.582 0.437	0.311 0.233	0.291 0.218	0.155 0.117	0.146 0.109	0.078 0.058	0.073 0.055	0.039 0.029
Total magnification o	n PC monitor		12.6	18	21.6	36	64.8	72	126	144	270	288	540	576	1080	1152	2160	2304	4320

^{*} Total magnification is that of video window with 640 × 480 pixels on 24 inch WUXGA monitor (1920 × 1200 pixels) recommended for VMZ-R series.

Type 1, 2 and 3 - Standard magnification zooming heads

Equipped with excellent Nikon optics

Zooming heads are equipped with 15x zoom optics made exclusively for the NEXIV VMZ-R series. These Nikon optics feature a long working distance, a high NA of 0.35, low distortion, and low magnification error.

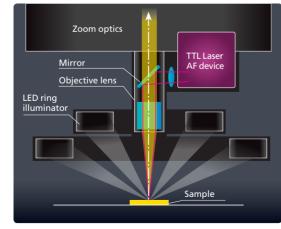


^{*} Total magnification is that of video window with 640 × 480 pixels on 24 inch WUXGA monitor (1920 × 1200 pixels) recommended for VMZ-R series.

TTL Laser AF with 50mm working distance (TTL - Through the lens)

Type 1, 2 and 3 zooming heads are equipped with TTL Laser AF with a long working distance 50mm. TTL Laser AF can work and show a high repeatability, independent from magnification used. It can also be used for scanning the surface by detecting a maximum of 1000 points per second. TTL Laser AF can detect both top and bottom surfaces of a transparent layer for measuring thickness of the transparent layer or the depth to surface of the layer under the transparent layer.

Focusing mode	Zooming head moves to focus point, passes it and returns to it.
Trigger mode	Zooming head moves to focus point and passes it and does not return to it (for reduction of measuring time).
Tracking mode	Zooming head moves to focus point and stops there and does not pass it (for further reduction of measuring time).
Searching mode	Zooming head detects 2 surfaces reflecting laser beam and you can choose a surface to detect.



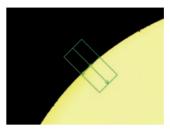
TTL Laser AF schematic

Measurement support provided by Vision AF

Used for samples difficult to detect with TTL Laser AF, Vision AF is suitable to measure the height of rough surfaces and depth of small/deep holes.



• Surface mode
Focus on surface of objects



Contrast mode
 Focus on edges contoured by the bottom light



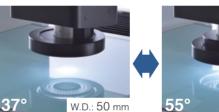
Multi mode
 Measure height of multiple points in the FOV



• 2 peak detection
Obtain higher or lower focus points

Versatile illumination designed for highlighting obscure edges

LED light sources have now replaced all the halogen light sources used on previous models. LEDs have a stable high color temperature, which does not change with intensity. This gives more natural images and shorter measurement times.



· LED inner ring light

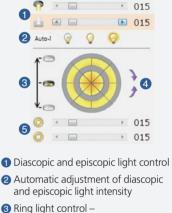


 LED outer ring light at 55 degree position

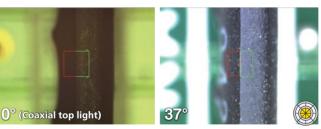


 LED outer ring light at 78 degree position

The inner 8 segment LED ring illuminator has 37 degree oblique angle to optical axis and the outer 8 segment LED ring illuminator has 55 and 78 degrees, that can easily define edges which are almost invisible to coaxial top light.

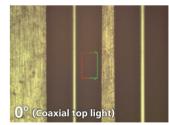


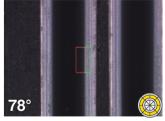
- angle and direction
- 4 Rotation of ring light direction
- **5** Ring light intensity control



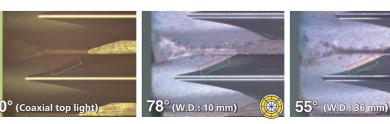
• Coaxial top light / 37 degree oblique light (Connector at optical magnification 5x)

Obscure edges under coaxial top light are visible with LED ring lights.





• Coaxial top light / 78 degree oblique light (Drill at optical magnification 5x)



- Coaxial top light / 78 degree oblique light / 55 degree oblique light

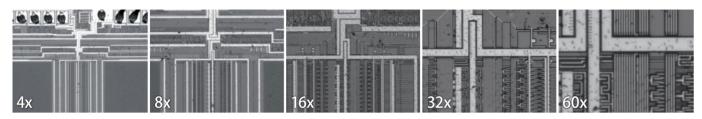
 (Prill at optical magnification 54)
- (Drill at optical magnification 5x)

An obscure edge under coaxial top light is visible with oblique lights.

55 degree oblique light with a 36 mm working distance has an effect similar to the 78 degree oblique light with a working distance of 10 mm.

Type 4 - High magnification zooming head

Ideal for measuring high density samples with tiny features



Type 4 has a 4 to 60× optical magnification, twice that of Type 3. The objective lens is designed with a high NA of 0.46 and a long working distance of 30mm.

Optical magnification	on	4	8	16	32	60		
FOV size on stage	Horizontal × Vertical (mm)	1.165 0.875	0.582 0.437	0.291 0.218	0.146 0.109	0.078 0.058		
1/3" CCD size	Horizontal × Vertical (mm)	4.8×3.6						
Video magnification		36						
Total magnification of (640 × 480 pixels)	n Video Window	144	288	576	1152	2160		
Size of 1 pixel (micron	neter)	1.84	0.82	0.46	0.23	0.12		
Size of objects on Video Window (640 × 480 pixels)	0.01× (mm) 0.1× (mm) 1× (mm)	1.44 14.4 144	2.88 28.8 288	5.76 57.6 576	11.52 115.2 1152	21.6 216 2160		

^{*} Total magnification is that of video window with 640 × 480 pixels on 24 inch WUXGA monitor (1920 × 1200 pixels) recommended for VMZ-R series.

8-segment LED ring illuminator suited for various samples

Type 4

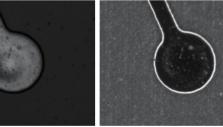
Type 4 is equipped with an 8-segment LED ring illuminator, as well as episcopic and diascopic illuminators, that make obscure edges stand out.

Subtle edges can be detected by utilizing the 50 degree oblique angle of the 8-segment ring illuminator.





High density PCB at optical magnification 4×



8-segment LED ring light



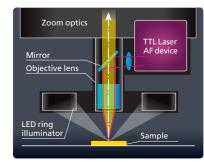
Lead frame Episcopic illumination at optical magnification 4x

2 types of AF available as standard

Type 4

TTL Laser AF

TTL Laser AF, with a working distance of 30mm, can detect both the top and bottom layers of thin samples, such as transparent samples of 0.1mm thickness. By scanning 1000 points per second, the TTL Laser AF not only offers high accuracy, but also speed



TTL Laser AF schematic

Vision AF

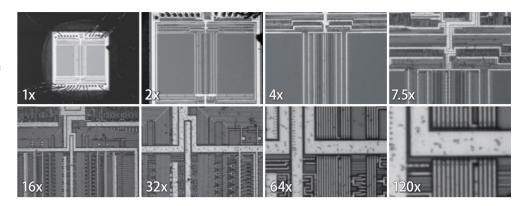
Vision AF can detect surfaces that cannot be reached with the Laser AF. The bottom surface of deep holes and the height of steep surfaces can be detected and measured with Vision AF.

Type TZ – High magnification zooming head

Type TZ zooming head range 1x to 120x

Type TZ

Type TZ high magnification zooming head is equipped with two objective lenses that can be easily switched, offering a total of 1 to 120x optical magnifications. From low magnification to high magnification to measure tiny features, such as 1 micrometer line width, Type Z covers a wide range of measurement area.

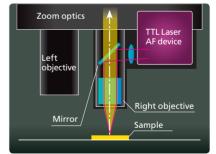


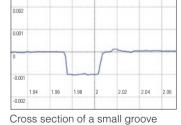
Optical magnification	1	2	4	7.5	16	32	64	120		
FOV size on stage	Horizontal × Vertical (mm)	4.7 3.5	2.33 1.75	1.165 0.875	0.622 0.467	0.291 0.218	0.146 0.109	0.073 0.055	0.039 0.029	
1/3" CCD size Horizontal × Vertical (mm)		4.8×3.6								
Video magnification	36									
Total magnification on Video Window (640 × 480	Total magnification on Video Window (640 × 480 pixels)		72	144	270	576	1152	2304	4320	
Size of 1 pixel (micrometer	Size of 1 pixel (micrometer)		3.68	1.84	0.98	0.46	0.23	0.11	0.06	
Size of objects on Video Window (640 × 480 pixels)	0.01× (mm) 0.1× (mm) 1× (mm)	0.36 3.6 36	0.72 7.2 72	1.44 14.4 144	2.7 27 270	5.76 57.6 576	11.52 115.2 1152	23.04 230.4 2304	43.2 432 4320	

^{*} Total magnification is that of video window with 640 x 480 pixels on 24 inch WUXGA monitor (1920 x 1200 pixels) recommended for VMZ-R series.

TTL Laser AF highest among the VMZ-R series

Type TZ main objective lens has TTL Laser AF built-in. High NA (0.55) lens has the highest performance in terms of detecting and scanning



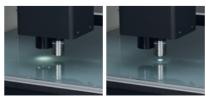


TTL Laser AF schematic

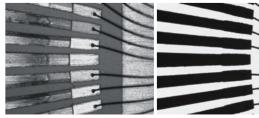
CNC controlled illuminations

Type TZ

Offers coaxial, episcopic, and darkfield illuminations to detect edges of tiny features.



 Objective lenses for Type TZ Left: 1 to 7.5× Right: 16 to 120×



Lead frame Coaxial illumination at optical magnification 1x

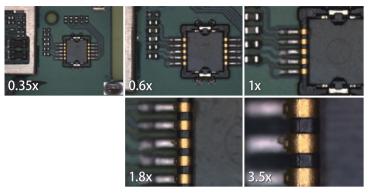




High density PCB Darkfield illumination at optical magnification 16x

Type A - Wide FOV zooming head

Features a wide FOV and long working distance

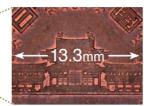


Optical magnificat	tion	0.35	0.6	1	1.8	3.5	
FOV size on stage	FOV size on stage Horizontal × Vertical (mm)		7.8 5.8	4.7 3.5	2.6 1.9	1.33 1.00	
1/3" CCD size	4.8×3.6						
Video magnification	36						
Total magnification Video Window (640	12.6	21.6	36	64.8	126		
Size of 1 pixel (micro	21.8	12.6	7.36	4.25	2.15		
$ \begin{array}{lll} \text{Size of objects on} & 0.01 \times \text{(mm)} \\ \text{Video Window} & 0.1 \times \text{(mm)} \\ \text{(640 \times 480 pixels)} & 1 \times \text{(mm)} \\ \end{array} $		0.126 1.26 12.6	0.216 2.16 21.6	0.36 3.6 36	0.648 6.48 64.8	1.26 12.6 126	

 $^{^*}$ Total magnification is that of video window with 640 \times 480 pixels on 24 inch WUXGA monitor (1920 \times 1200 pixels) recommended for VMZ-R series.

With a maximum of 13.3×10 mm FOV at $0.35 \times$, the wide FOV is available for samples with large features.





10 yen coin Under coaxial top light at 0.35× optical magnification

At all magnifications, a working distance of 73.5 mm can be realized. Type A is suitable for measuring low density samples with wide steps and/or deep holes.



Working distance 73.5 mm



Assembled components
Under coaxial top light
at 0.35× optical magnification

Vision AF and Laser AF

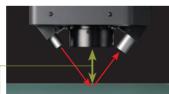
The search probe can detect misaligned parts, and rotate the program to suit, allowing for successful measurement with the Vision AF. With a 63 mm working distance, the Laser AF option for Type A offers high accuracy, independent of magnification and its depth of focus.



Focusing on a surface (Vision AF Surface mode)



Focusing on an edge (Vision AF Contrast mode)



Working distance
63 mm (Laser AF)

Illumination lineup for various needs

Equipped with episcopic, diascopic and 8-segment ring illuminators.

Obscure edges can be visualized by using the 8-segment ring illuminator with an oblique angle of 18 degrees.



Plastic molded part Under coaxial top light at 0.35× optical magnification



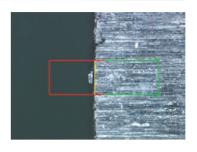
Episcopic illumination



Software

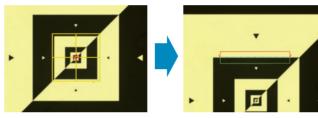
Edge and point selection

Preset rules for selecting the correct edge with multiple edge candidates and a filter to avoid abnormal points to minimize errors.

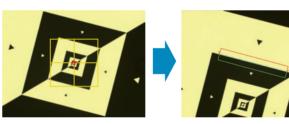


Intelligent search function

Measures by searching preset shapes/patterns. Misaligned samples can be found and measured without failure.



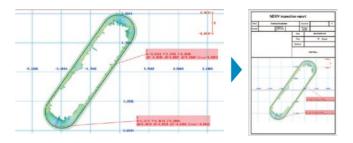
Automatically finds the shape that was preset



"Rotate search" detects the misaligned samples and automatically rotates the program to suit for measurement.

Evaluation of shapes

Errors can be visualized by overlaying nominal and measured shapes. Can be used for both geometrical shapes and free-form shapes.



- Calculation of errors can be made in normal or axis direction
- Nominal shapes can be made from CAD data or XYZ coordinate values
- Measured shapes can be output as CSV or DXF files
- Evaluation reports can be made in PDF files

Digital Operation Guide NEXIV Note Ver.1.0

Offers slides and movies with NEXIV contents, such as basic operations and fuctions. Simple measurement programs can be created by referring to this application.



- Search: search by related words
- · Favorite: list only selected contents
- Memo: share information by creating memos
- Pack List: sort by related contents
- Stay on top: display in the foreground on screen



Other functions

Import of CAD data

CAD data can be imported and shown in the graphic window.

Export of DXF data ...

Features measured can be exported as DXF data.

Off-line teaching

Teaching files can be made on CAD data.

Reporting measured data

Easily made by choosing graphics and layouts.

Calculations based on ISO and JIS standards

Circle (roundness), plane (flatness), line (straightness) are available.

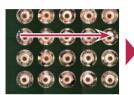
Optional Software

EDF/Stitching Express

Images taken with the VMZ-R can be stitched to get a larger image, while images at different heights can result with an image with Extended Depth of Focus (EDF). Stitching and EDF can produce 3D graphics.

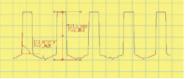


Original image



Original image

3D graphic from EDF



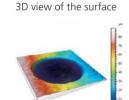
Cross section from EDF and Stitching

MountainsMap X

Sample surfaces can be analyzed, based on ISO, with the data exported from VMZ-R.

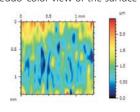
Manufactured by Digital Surf (France)

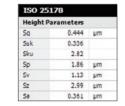
Pseudo-color view of the surface

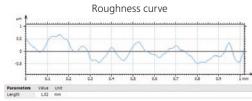




Pseudo-color view of the surface







ImageFit QC

Creates inspection reports according to any designated format. Measurement results can be automatically reflected with pass/fail results and statistical results*. Line graphs and histograms can also be created as needed.

*standard deviation, process capability index (Cp, Cpk)

*Excel is required

Codeveloped by Aria Co., Ltd. (Japan)



Parameter Settings

Report of Measurement Results

Custom Fit QC

Measurement results are read into 10 different templates and pass/fail results and calculation results*1 are automatically exported. Graphs*2, including X-R control charts and scatter diagrams, can be automatically generated to visualize measurement results.

*1: Average, maximum value, minimum value, range, standard deviation, and process capability index (Cp, Cpk)

*2: Line graphs, histograms, X-R control charts, scatter diagrams

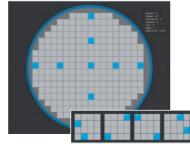
*Excel is required

Codeveloped by Aria Co., Ltd. (Japan)



MapMeasure Pro

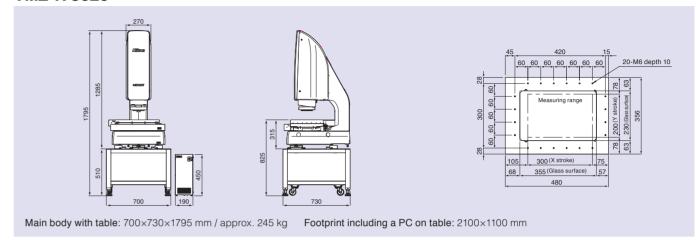
MapMeasure Pro creates wafer maps and is capable of automatically measuring any die on the wafer map. Tray maps can also be created.



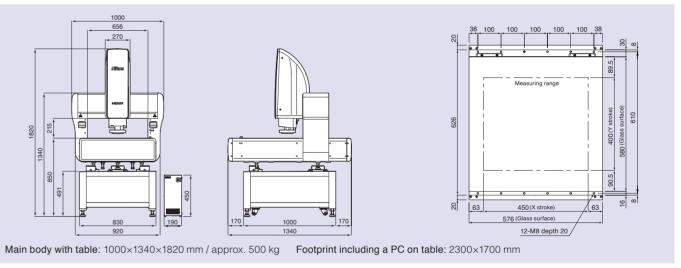
Dimensions

Controller: 190×450×440 mm / 15 kg

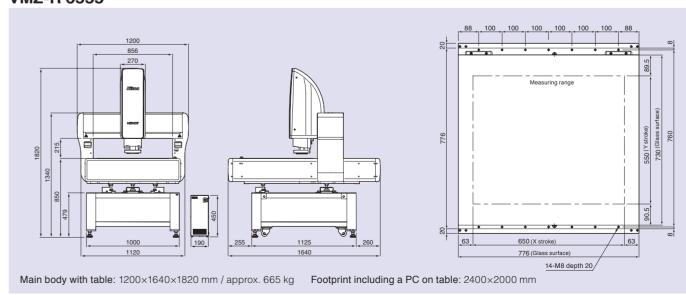
VMZ-R 3020



VMZ-R 4540



VMZ-R 6555



pecifications

Model	VMZ-R 3020	VMZ-R 4540	VMZ-R 6555				
XYZ strokes	VIWE-11 0020	VIVIZ-11 4340	VIVIZ-11 0333				
Type 1, 2, 3 and 4	300×200×200 mm	450×400×200 mm	650×550×200 mm				
Type TZ with high magnification lens	300×200×200 mm	450×400×200 mm	650×550×200 mm				
Type TZ with low magnification lens	250×200×200 mm	400×400×200 mm	600×550×200 mm				
Type A	300×200×200 mm	450×400×200 mm	650×550×200 mm				
Minimum readout	0.01 micrometer						
Maximum sample weight	20 kg	40 kg	50 kg				
Maximum permissible error (L: Length in mm)	Eux, MPE Euy, MPE: 1.2+4 <i>L</i> /1000 μm Euxy, MPE: 2+4 <i>L</i> /1000 μm Euz, MPE: 1.2+5 <i>L</i> /1000 μm						
Camera	1/3" Black and White CCD, 1/3" Color CCD *Color camera option is available only with Type 1, 2 and A						
Working distance of objective lens							
Type 1, 2 and 3	50 mm with 37 degree oblique angle, 36 mm with 55 degree oblique angle, 10 mm with 78 degree oblique angle						
Type 4	30 mm						
Type TZ	11 mm with right objective lens, 32 mm with left objective lens						
Type A	73.5 mm (63 mm with Laser AF)						
Magnification and FOV							
Autofocus	Vision AF, Laser AF (option)						
Illumination							
Type 1, 2, 3, and 4	Episcopic, diascopic, and 8-segme	nt ring with 3 angles *All white LED/T	ype 4 has only 1 angle				
Type TZ	Left objective lens: Episcopic, darkfield; Right objective lens: Episcopic, diascopic, darkfield						
Type A	Episcopic, diascopic, and 8-segment ring with 1 angle *All white LED						
Power source	AC 100-240V±10% 50/60 Hz						
Power consumption	5 A - 2.5 A						

Nikon Corporation Industrial Metrology Business Unit is certified as an ISO/IEC 17025 accredited calibration laboratory for CNC video measuring systems by the IAJapan (International Accreditation Japan) as Accreditation No.JCSS0241.

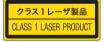
ISO/IEC 17025: International standard, which specifies the general requirements to ensure that a laboratory is competent to carry out specific tests and/or calibrations

Date of initial accreditation:	July 1, 2009
Scope of accreditation:	Coordinate measuring instruments
Accredited section:	Industrial Metrology Business Unit
Calibration site:	Customer's laboratory (field service)
Calibration and Measurement Capability (CMC), (K=2, Level of Confidence Approximately 95%) [L=measurement length (mm)]	L ≤ 420mm: 0.32 µm 420 ≤ L ≤ 1000mm : (0.29 + 0.64 × L/1000) µm

Specifications and equipment are subject to change without any notice or obligation on the part of the manufacturer. March 2020 ©2013-2020 NIKON CORPORATION

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